

# TEST DRIVE THE LATEST PHENOM SEM



Originally developed by Philips/FEI in Eindhoven and further developed by Phenom-World

Fast and easy to use Scanning Electron Microscope requiring no previous SEM experience

## Phenom ProX with X-ray analysis

The Phenom desktop SEM is an **affordable, fast and easy to use tool** suitable for investigating micron and submicron structures in high resolution. The Phenom SEM offers **fully integrated x-ray analysis (EDS)**, fastest time to **imaging (<30sec)** and **“never lost” navigation**. This workshop will enable you experience the Phenom SEM instrument via scheduled demonstrations followed by additional “hands on” time for sample analysis.

**Date:** Wed 23rd and Thur 24th September 2015

**Location:** Monash Centre for Electron Microscopy, 10 Innovation Walk, Room G11, Clayton campus, Monash University

Further details available upon registration

**DEMONSTRATION:** 9am-10am and repeated 1pm-2pm daily. Following each demonstration the Phenom SEM will be available for participants to operate and for sample analysis.

**HANDS ON:** *Morning sessions start from 10am to 12pm*  
*Afternoon sessions start from 2.00pm to 4pm*

**REGISTRATION:** Please register using the online form

[www.atascientific.com.au/eventsandtraining/registration-page/](http://www.atascientific.com.au/eventsandtraining/registration-page/)

**RSVP: 21 September 2015**

For further information, call **02 9541 3500** or

email [enquiries@atascientific.com.au](mailto:enquiries@atascientific.com.au)

